36	earch No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/521,250	VAN ARENDONK ET AL.	
Examiner	Art Unit	
LUONG T. NGUYEN	2622	

	SEARCHED		
Class	Subclass	Date	Examiner
348	340 374	1/20/2008	LN
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INTERFERENCE SEARCHED			
Class	Subclass	. Date	Examiner
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
348/335,340,373,374 (text search only, see search history printout)	1/20/2008	LN
EAST (USPAT; USPG_PUB; JPO; EPO; DERWENT; IBM_TDB) see search history printout	1/20/2008	LN
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